# ELEC 207 Instrumentation and Control

### 12 – Noise and Interference

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# Signal processing

### Analog and digital processing

A measurement signal is often processed to extract relevant information or to "clean" it by removing noise and other disturbances.

There are two types of signal processing:

### Analog signal processing:

- Applied to an analog signal (e.g. before the ADC);
- A typical example is **filtering** to remove noise;

### Digital signal processing:

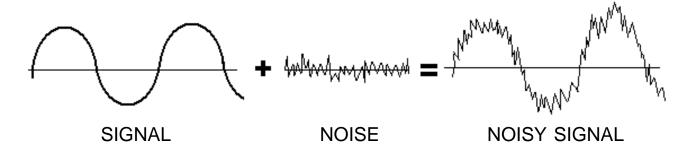
- Applied to a digital signal (e.g. after the ADC);
- > Typical examples are the **calculation** of the signal RMS value or the **transformation** of the signal into the frequency domain, etc.



# Signal and noise

#### Internal noise and external interference

**Noise** is an undesired disturbance, superimposed to the measurement signal, which affects the quality (and therefore the accuracy) of the signal:



The quality of the signal can be measured by the signal-to-noise ratio
(SNR), which is the ratio between the signal power and the noise power.

Noise in a measurement system can arise from two sources:

- Internal (e.g. thermal noise);
- External (interference from other circuits).



### Electromagnetic interference

Overview and general solutions

Electromagnetic interference from external (power) circuits is quite common, particularly in industrial environments:

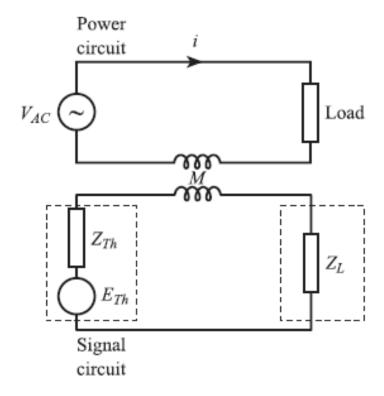
- It is caused by **inductive and/or capacitive coupling** between the measurement circuit and other (power) circuits near it;
- It typically produces noise at high frequency because the coupling is more effective at higher frequencies;
- The coupling (and therefore the noise) can be decreased by separating the measurement circuit from the other circuits, but this is not always possible:
  - > E.g. when the measurand is a quantity in the power circuit itself;
  - Therefore other solutions are required.



# Inductive coupling

Cause of the problem

A strong time-varying magnetic field (typically originated from a power circuit) near the measurement circuit may induce a voltage in the measurement circuit due to inductive coupling:



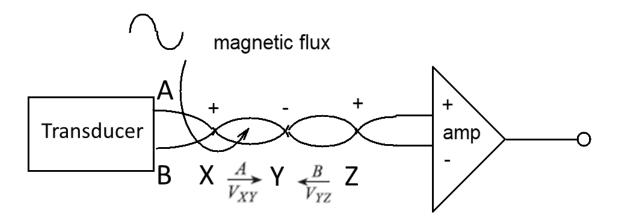


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# Inductive coupling

#### Possible solution

A possible way to decrease the induced voltage in the measurement circuit is to **twist the wires** in the measurement circuit:



- This has two positive effects:
  - The loop area is reduced to a minimum value;
  - ➤ The voltages induced in adjacent loops are opposite, so they balance out and (ideally) the overall induced voltage is zero.

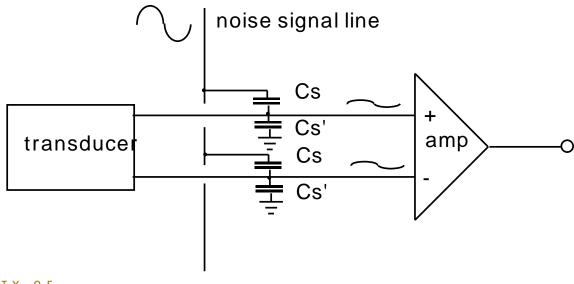


# Capacitive coupling

### Cause of the problem

Wires are conductors, so there is always a capacitance between wires in different circuits (e.g. the measurement circuit and a power circuit near it):

This capacitive coupling may induce voltages in the measurement circuit.



# Capacitive coupling

Possible solutions (1)

The induced voltage due to capacitive coupling is usually a **common-mode voltage**, i.e. it is the same on the two wires of the measurement circuit:

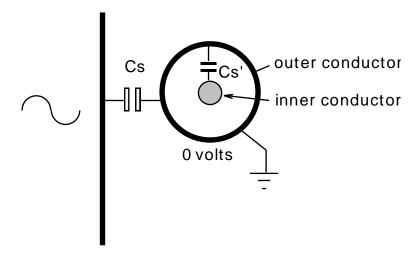
- Therefore it can be easily removed by a differential amplifier, which amplifies only the difference between the voltages at the two terminals;
- The effectiveness in removing the capacitive coupling is measured by the common-mode rejection ratio (CMRR) of the amplifier, which is the ratio between the differential voltage amplification and the common-mode voltage amplification:
  - The higher the CMRR the better;
  - ➤ Instrumentation amplifiers have a very high CMRR (above 100 dB) and are particularly suitable for measurement applications.



# Capacitive coupling

Possible solutions (2)

Another possible solution to decrease the interference arising from capacitive coupling is to use a **shielded (or screened) cable** for the measurement circuit, with the shield grounded:



 The shield could be either the negative (reference) terminal in the measurement circuit or a third conductor.



# **Ground loops**

### Cause of the problem

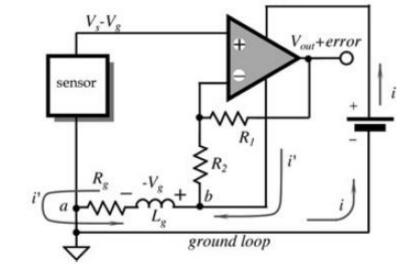
Another source of possible noise is represented by **multiple ground points** in the circuit:

The ground resistance and inductance are not zero as in an ideal circuit:

> Therefore current flowing through a ground path creates a voltage drop,

which means that two reference points in the circuit (two 'grounds') may actually be at different potentials;

➤ Also, a **ground loop** in the circuit is a source of noise.



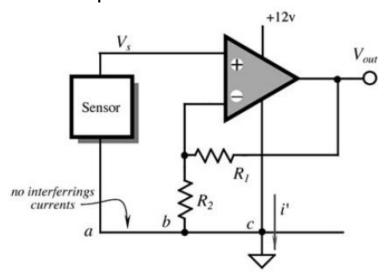
+12v



# **Ground loops**

#### Possible solution

To avoid ground loops, the whole circuit should be **connected to ground only in one point**, and all elements in the circuit (transducer, amplifier, etc.) should be referenced to this common point:



• When connecting an additional element to the circuit (e.g. an oscilloscope to acquire a voltage signal), it is very important to know whether it adds another ground connection and therefore a possible ground loop.



### References

Textbook: Principles of Measurement Systems, 4th ed.

For further explanation about the points covered in this lecture, please refer to the following chapters and sections in the **Bentley** textbook:

- Chapter 6, Sec. 6.3: Effects of noise and interference on measurement circuits;
- Chapter 6, Sec. 6.4: Noise sources and coupling mechanisms;
- Chapter 6, Sec. 6.5: Methods of reducing effects of noise and interference.

<u>NOTE</u>: Topics not covered in the lecture are not required for the exam.



### References

Textbook: Measurement and Instrumentation, 2<sup>nd</sup> ed.

For further explanation about the points covered in this lecture, please refer to the following chapters and sections in the **Morris-Langari** textbook:

- Chapter 3, Sec. 3.6: Induced measurement noise;
- Chapter 3, Sec. 3.7: Techniques for reducing induced measurement noise.

NOTE: Topics not covered in the lecture are not required for the exam.

